# onsemi

### Si/SiC Hybrid Modules – EliteSiC, 3 Channel Flying Capacitor Boost 1000 V, 100 A IGBT, 1200 V, 30 A SiC Diode, Q2 Package

## NXH300B100H4Q2F2, NXH300B100H4Q2F2SG-R

This high-density, integrated power module combines high-performance IGBTs with 1200 V SiC diode.

#### Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- 3-channel in Q2BOOST Package
- These are Pb-Free Devices

#### **Typical Applications**

- Solar Inverter
- Uninterruptible Power Supplies

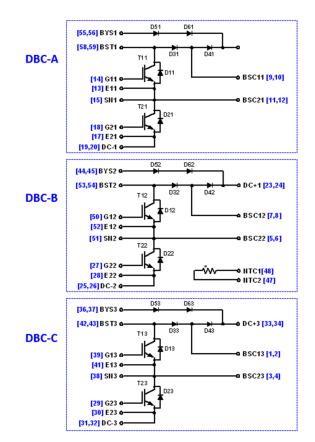
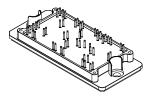


Figure 1. NXH300B100H4Q2F2PG/SG/SG-R Schematic Diagram

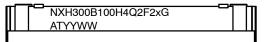


PIM53, 93x47 (PRESSFIT) CASE 180CB



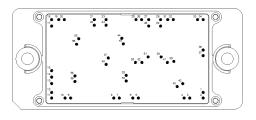
PIM53, 93x47 (SOLDER PIN) CASE 180CC

#### MARKING DIAGRAM



NXH300B100H4Q2F2>	x = Specific Device Code
AT	(x = P, S) = Assembly & Test Site Code
YYWW	= Year and Work Week Code

#### **PIN CONNECTION**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 11 of this data sheet.

#### **ABSOLUTE MAXIMUM RATINGS** (Note 1) (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
IGBT (T11	, T21, T12, T22, T13, T23)		
V <sub>CES</sub>	Collector-Emitter voltage	1000	V
V <sub>GE</sub>	Gate-Emitter Voltage Positive transient gate-emitter voltage (Tpulse = 5 $\mu$ s, D < 0.10)	±20 30	V
Ι <sub>C</sub>	Continuous Collector Current (@ $V_{GE}$ = 20 V, $T_C$ = 80°C)	73	А
I <sub>C(Pulse)</sub>	Pulsed Peak Collector Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	219	А
P <sub>tot</sub>	Power Dissipation ( $T_J = 150^{\circ}C$ , $T_C = 80^{\circ}C$ )	194	W
T <sub>JMIN</sub>	Minimum Operating Junction Temperature	-40	°C
T <sub>JMAX</sub>	Maximum Operating Junction Temperature	175	°C

IGBT INVERSE DIODE (D11, D21, D12, D22, D13, D23) AND BYPASS DIODE (D51, D61, D52, D62, D53, D63)

V <sub>RRM</sub>	Peak Repetitive Reverse Voltage	1600	V
١ <sub>F</sub>	Continuous Forward Current @ T <sub>C</sub> = 80°C	36	Α
I <sub>FRM</sub>	Repetitive Peak Forward Current ( $T_J$ = 150°C, $T_J$ limited by $T_{Jmax}$ )	108	А
P <sub>tot</sub>	Maximum Power Dissipation @ $T_{C}$ = 80°C ( $T_{J}$ = 150°C)	79	W
$T_{JMIN}$	Minimum Operating Junction Temperature	-40	°C
T <sub>JMAX</sub>	Maximum Operating Junction Temperature	150	°C

#### BOOST SILICON CARBIDE SCHOTTKY DIODE (D31, D41, D32, D42, D33, D43)

V <sub>RRM</sub>	Peak Repetitive Reverse Voltage	1200	V
١ <sub>F</sub>	Continuous Forward Current @ T <sub>C</sub> = 80°C	36	А
I <sub>FRM</sub>	Repetitive Peak Forward Current ( $T_J$ = 150°C, $T_J$ limited by $T_{Jmax}$ )	108	А
P <sub>tot</sub>	Maximum Power Dissipation @ $T_{C}$ = 80°C ( $T_{J}$ = 150°C)	104	W
T <sub>JMIN</sub>	Minimum Operating Junction Temperature	-40	°C
T <sub>JMAX</sub>	Maximum Operating Junction Temperature	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

#### **THERMAL AND INSULATION PROPERTIES** (Note 1) (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol Rating		Value	Unit				
THERMAL	PROPERTIES						
T <sub>VJOP</sub>	Operating Temperature under Switching Condition	-40 to 150	°C				
T <sub>stg</sub>	Storage Temperature Range	-40 to 125	°C				

#### **INSULATION PROPERTIES**

V <sub>is</sub>	Isolation Test Voltage, t = 2 sec, 50 Hz (Note 3)	4000	V <sub>RMS</sub>
	Creepage Distance	12.7	mm
CTI	Comparative Tracking Index	>600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

3. 4000 VAC<sub>RMS</sub> for 1 second duration is equivalent to 3333 VAC<sub>RMS</sub> for 1 minute duration.

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
GBT (T11, 1	[21, T12, T22, T13, T23)			•		
V <sub>(BR)CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> =1 mA	1000	1118	-	V
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation Voltage	$V_{GE}$ = 15 V, I <sub>C</sub> = 100 A, T <sub>C</sub> = 25°C	_	1.80	2.25	V
		$V_{GE}$ = 15 V, I <sub>C</sub> = 100 A, T <sub>C</sub> = 150°C	_	2.03	-	
V <sub>GE(TH)</sub>	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 100 \text{ mA}$	4.1	5.08	5.9	V
I <sub>CES</sub>	Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1000 V	_	-	800	μA
I <sub>GES</sub>	Gate Leakage Current	$V_{GE} = \pm 20 \text{ V}, \text{ V}_{CE} = 0 \text{ V}$	-	-	±400	nA
r <sub>g</sub>	Internal Gate Resistor		-	5	-	Ω
t <sub>d(on)</sub>	Turn-On Delay Time	$T_j = 25^{\circ}C$	-	95	-	ns
t <sub>r</sub>	Rise Time	$V_{CE}$ = 600 V, I <sub>C</sub> = 50 A V <sub>GE</sub> = -9 V, +15 V, R <sub>G</sub> = 6 Ω	_	15.42	-	
t <sub>d(off)</sub>	Turn-Off Delay Time		_	267	-	
t <sub>f</sub>	Fall time		_	59	-	
Eon	Turn on switching loss	1	_	1030	-	μJ
E <sub>off</sub>	Turn off switching loss		_	1200	-	
t <sub>d(on)</sub>	Turn-On Delay Time	$T_{j} = 125^{\circ}C$	_	97	-	ns
t <sub>r</sub>	Rise Time	$V_{CE}$ = 600 V, I <sub>C</sub> = 50 A V <sub>GE</sub> = -9 V, +15 V, R <sub>G</sub> = 6 Ω	-	18	-	
t <sub>d(off)</sub>	Turn-Off Delay Time		_	314	-	
t <sub>f</sub>	Fall time		_	93	-	
Eon	Turn on switching loss		_	1260	-	μJ
E <sub>off</sub>	Turn off switching loss		_	2140	-	
C <sub>ies</sub>	Input capacitance	$V_{CE}$ =20 V, $V_{GE}$ = 0 V, f = 1 MHz	_	6323	-	pF
C <sub>oes</sub>	Output capacitance	]	_	241	-	
C <sub>res</sub>	Reverse transfer capacitance	]	_	34	-	
Qg	Gate Charge	$V_{CE}$ = 600 V, $V_{GE}$ = –15/+15 V, $I_{C}$ = 75 A	_	340	-	nC
R <sub>thJH</sub>	Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	_	0.66	_	K/W
R <sub>thJC</sub>	Thermal Resistance - chip-to-case	$\lambda = 2.9 \text{ W/mK}$	_	0.48	_	K/W

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

#### IGBT INVERSE DIODE (D11, D21, D12, D22, D13, D23) AND BYPASS DIODE (D51, D61, D52, D62, D53, D63)

V <sub>F</sub>	Diode Forward Voltage	$I_F = 30 \text{ A},  \text{T}_\text{J} = 25^\circ\text{C}$	_	1.04	1.7	V	ĺ
		I <sub>F</sub> = 30 A, T <sub>J</sub> = 150°C	-	0.94	-		
R <sub>thJH</sub>	Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ $\lambda$ = 2.9 W/mK	-	1.04	_	K/W	

#### BOOST SILICON CARBIDE SCHOTTKY DIODE (D31, D41, D32, D42, D33, D43)

I <sub>R</sub>	Diode Reverse Leakage Current	$V_{\rm R} = 1200 \text{ V}, \text{ T}_{\rm J} = 25^{\circ}\text{C}$	—	-	600	μΑ
V <sub>F</sub>	Diode Forward Voltage	$I_F = 30 \text{ A}, T_J = 25^{\circ}\text{C}$	-	1.42	1.7	V
		$I_F = 30 \text{ A},  \text{T}_\text{J} = 150^\circ\text{C}$	-	1.85	-	
t <sub>rr</sub>	Reverse Recovery Time	$T_J = 25^{\circ}C$	-	15	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$V_{DS} = 600 \text{ V}, \text{ I}_{C} = 50 \text{ A}$ $V_{GE} = -9 \text{ V}, 15 \text{ V}, \text{ R}_{G} = 1 \Omega$	-	128	-	nC
I <sub>RRM</sub>	Peak Reverse Recovery Current		-	13	-	А
di/dt	Peak Rate of Fall of Recovery Current		-	4200	-	A/μs
E <sub>rr</sub>	Reverse Recovery Energy		_	16	-	μJ

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
BOOST SIL	ICON CARBIDE SCHOTTKY DIODE (D31,	D41, D32, D42, D33, D43)				<u>.</u>
t <sub>rr</sub>	Reverse Recovery Time	$T_J = 125^{\circ}C$	-	19	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	- V <sub>DS</sub> = 600 V, I <sub>C</sub> = 50 A V <sub>GE</sub> = -9 V, 15 V, R <sub>G</sub> = 1 Ω	-	175	-	nC
I <sub>RRM</sub>	Peak Reverse Recovery Current	7	-	17	-	А
di/dt	Peak Rate of Fall of Recovery Current		-	3153	-	A/μs
E <sub>rr</sub>	Reverse Recovery Energy		-	18	-	μJ
R <sub>thJH</sub>	Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	-	0.85	-	K/W
R <sub>thJC</sub>	Thermal Resistance - chip-to-case	– λ = 2.9 W/mK	-	0.73	-	K/W
HERMISTO	OR CHARACTERISTICS					-
R <sub>25</sub>	Nominal resistance		_	22	-	kΩ
R <sub>100</sub>	Nominal resistance	T = 100°C	-	1486	-	Ω
$\Delta R/R$	Deviation of R25		-5	-	5	%
PD	Power dissipation		-	200	-	mW
	Power dissipation constant		-	2	-	mW/k
	B-value	B (25/50), tolerance ±3%	-	3950	-	К
	B-value	B (25/100), tolerance ±3%	_	3998	-	К

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

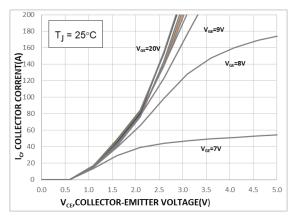


Figure 2. Typical Output Characteristics

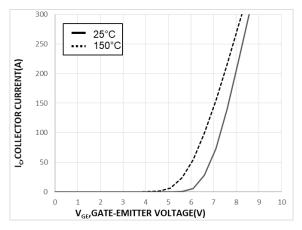


Figure 4. Transfer Characteristics

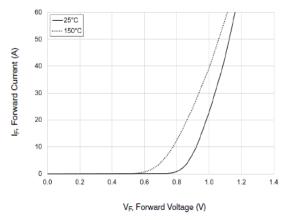


Figure 6. Inverse Diode Forward Characteristics

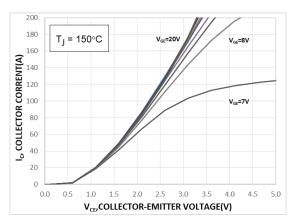


Figure 3. Typical Output Characteristics

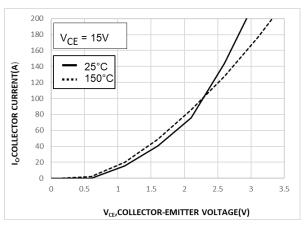


Figure 5. Typical Saturation Voltage Characteristics

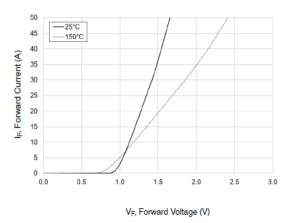


Figure 7. Boost Diode Forward Characteristics

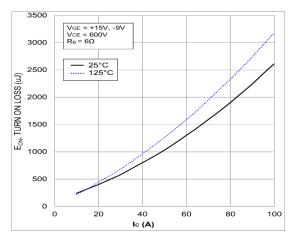


Figure 8. Typical Turn On Loss vs. I<sub>C</sub>

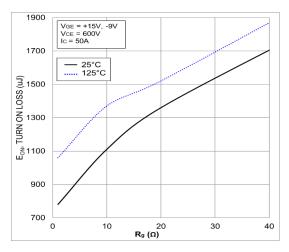


Figure 10. Typical Turn On Loss vs. R<sub>q</sub>

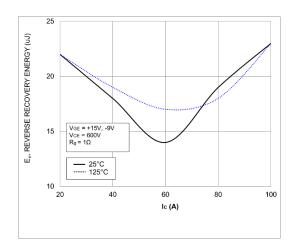


Figure 12. Typical Reverse Recovery Energy Loss vs. I<sub>C</sub>

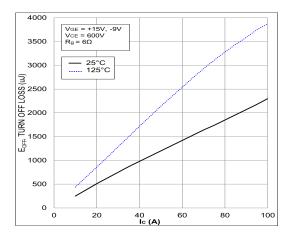


Figure 9. Typical Turn Off Loss vs. I<sub>C</sub>

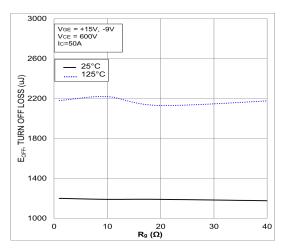
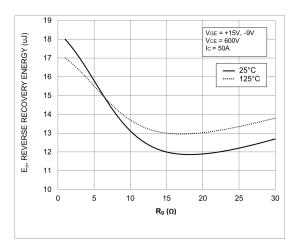
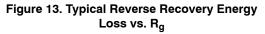


Figure 11. Typical Turn Off Loss vs. R<sub>q</sub>





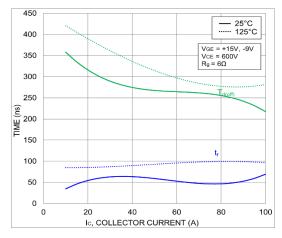


Figure 14. Typical Turn-Off Switching Time vs. IC

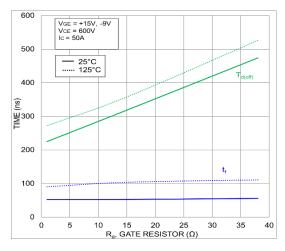


Figure 16. Typical Turn-Off Switching Time vs. Rg

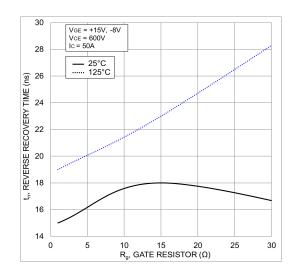


Figure 18. Typical Reverse Recovery Time vs. Rg

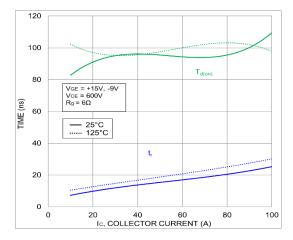


Figure 15. Typical Turn-On Switching Time vs. IC

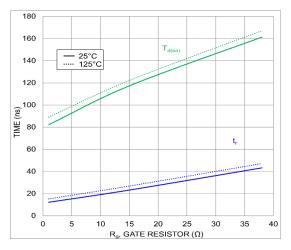


Figure 17. Typical Turn-On Switching Time vs. Rg

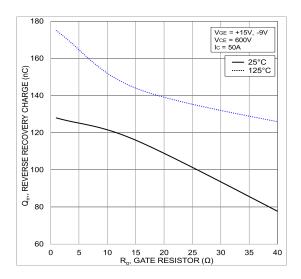


Figure 19. Typical Reverse Recovery Charge vs. Rg

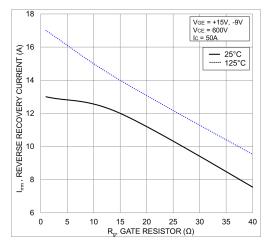


Figure 20. Typical Reverse Recovery Peak Current vs.  $R_{\alpha}$ 

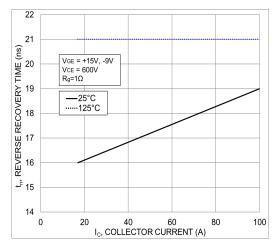


Figure 22. Typical Reverse Recovery Time vs.  $\rm I_{C}$ 

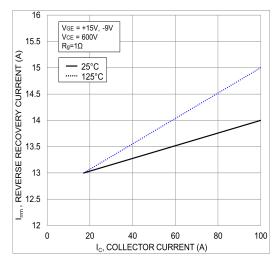


Figure 24. Typical Reverse Recovery Current vs.  $\rm I_{C}$ 

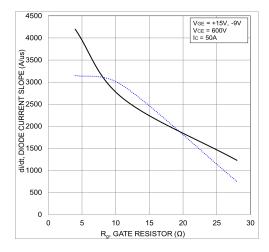


Figure 21. Typical di/dt vs. R<sub>g</sub>

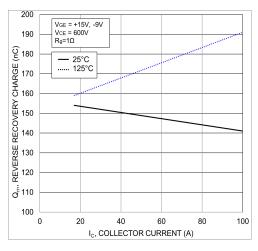


Figure 23. Typical Reverse Recovery Charge vs.  ${\rm I}_{\rm C}$ 

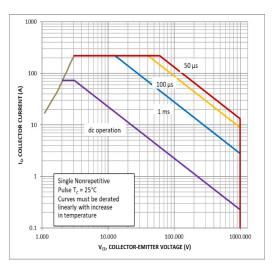


Figure 25. FBSOA

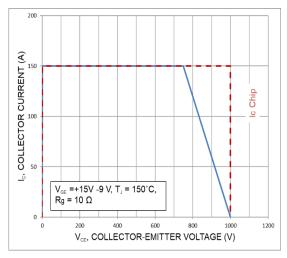


Figure 26. RBSOA

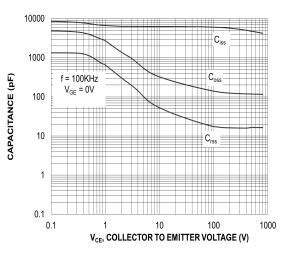


Figure 27. Capacitance Charge

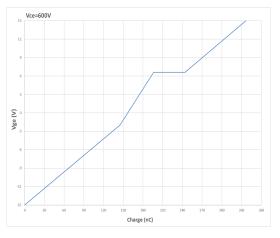


Figure 28. Gate Voltage vs. Gate Charge

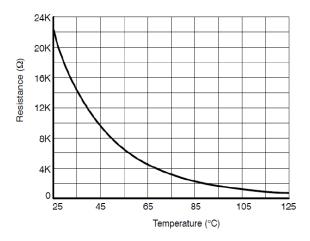


Figure 29. NTC Characteristics

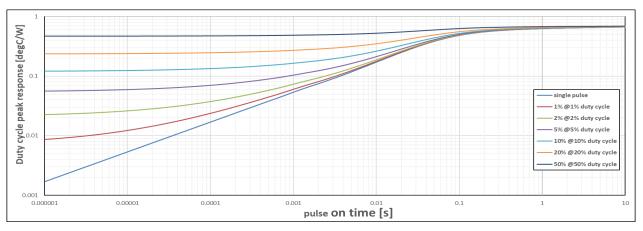


Figure 30. Transient Thermal Impedance (IGBT)

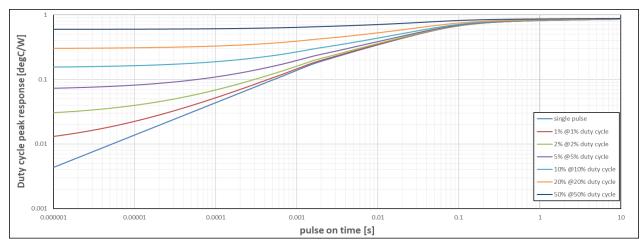
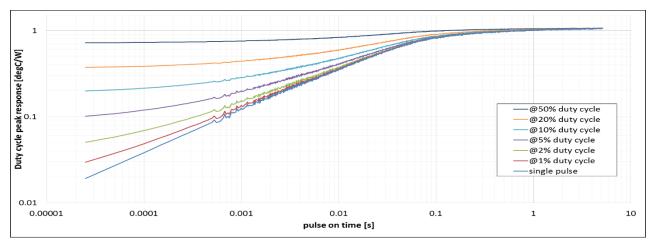
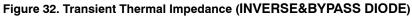


Figure 31. Transient Thermal Impedance (BOOST DIODE)

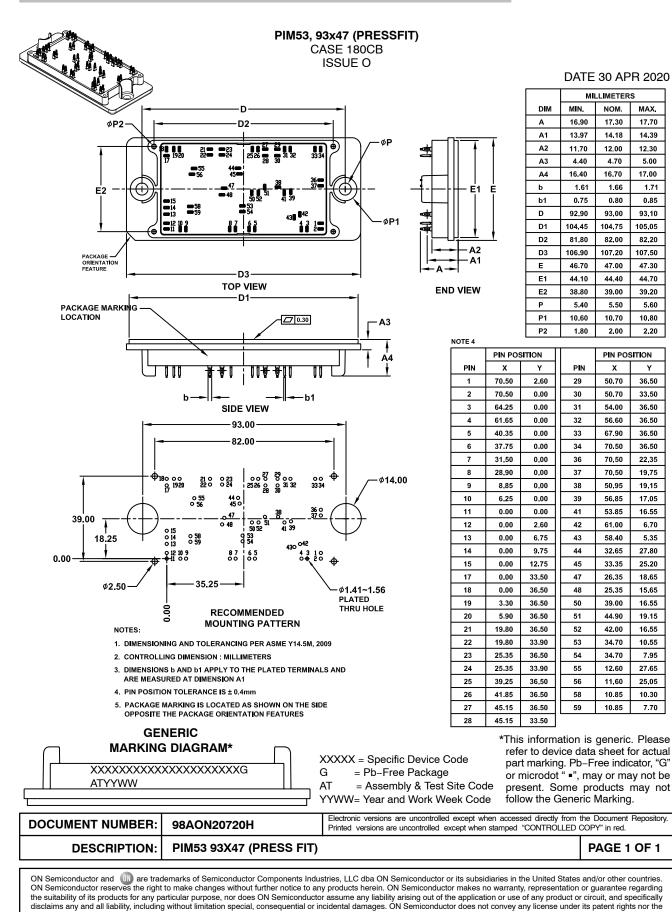




#### ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH300B100H4Q2F2PG PRESS FIT PINS	NXH300B100H4Q2F2PG	Q2BOOST – PIM53, 93x47 (PRESSFIT) (Pb-Free and Halide-Free Press Fit Pins)	12 Units / Blister Tray
NXH300B100H4Q2F2SG, NXH300B100H4Q2F2SG-R SOLDER PINS	NXH300B100H4Q2F2SG, NXH300B100H4Q2F2SG-R	Q2BOOST – PIM53, 93x47 (SOLDER PIN) (Pb-Free and Halide-Free Solder Pins)	12 Units / Blister Tray

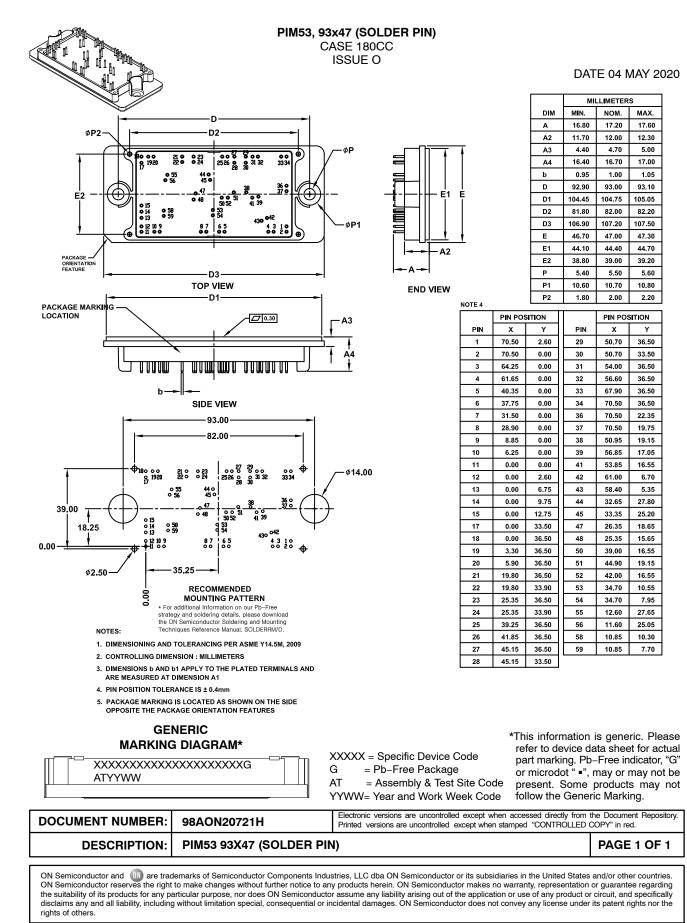




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 FP10R12W1T4\_B11
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 FZ1600R17HP4\_B2

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 FZ600R65KE3
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 DZ800S17K3
 F12 

 25R12KT4G
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 F31300R12ME4\_B22
 F3175R07W2E3\_B11
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 FD400R12KE3\_B5
 F475R07W1H3B11ABOMA1